Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,893	YUN ET AL.	
Examiner	Art Unit	
Brian Young	2819	

	05:-		
SEARCHED			
Class	Subclass	Date	Examiner
348	294,295, 300,301, 302,303, 308	5/13/2005	ВҮ
341	155,137		BY
257	222		BY
250	208.1		BY .
		O .	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
341	155	5/13/2005	BY	
	·			
			;	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (jpo,epo,derwent,etc) NPL (IEEE, portall)	5/13/2005	BY .
,		
•		